Hot-Swappable, Dual I²C Isolators, 5 kV

ADuM2250/ADuM2251

FEATURES

Bidirectional I²C communication
Open-drain interfaces
Suitable for hot-swap applications
30 mA current sink capability
1000 kHz operation
3.0 V to 5.5 V supply/logic levels
16-lead SOIC wide body package version (RW-16)
16-lead SOIC wide body enhanced creepage version (RI-16)
High temperature operation: 105°C
Safety and regulatory approvals (RI-16 package)
    UL recognition: 5000 V rms for 1 minute per
        UL 1577
    CSA Component Acceptance Notice #5A
        IEC 60601-1: 250 V rms (reinforced)
        IEC 60950-1: 400 V rms (reinforced)
    VDE Certificate of Conformity
        DIN V VDE V 0884-10 (VDE V 0884-10):2006-12
        V_{IORM} = 846 V peak

APPLICATIONS

Isolated I²C, SMBus, or PMBus Interfaces
Multilevel I²C interfaces
Power supplies
Networking
Power-over-Ethernet

GENERAL DESCRIPTION

The ADuM2250/ADuM2251[1] are hot-swappable digital isolators with nonlatching bidirectional communication channels that are compatible with I²C® interfaces. This eliminates the need for splitting I²C signals into separate transmit and receive signals for use with standalone optocouplers.

The ADuM2250 provides two bidirectional channels supporting a complete isolated I²C interface. The ADuM2251 provides one bidirectional channel and one unidirectional channel for those applications where a bidirectional clock is not required.

The ADuM2250/ADuM2251 contain hot-swap circuitry to prevent data glitches when an unpowered card is inserted onto an active bus.

These isolators are based on iCoupler® chip-scale transformer technology from Analog Devices, Inc. iCoupler is a magnetic isolation technology with performance, size, power consumption, and functional advantages compared to optocouplers. The ADuM2250/ADuM2251 integrate iCoupler channels with semiconductor circuitry to enable a complete, isolated I²C interface in a small form-factor package.

[1] Protected by U.S. Patents 5,952,849; 6,873,065; and 7,075,329; other patents pending.
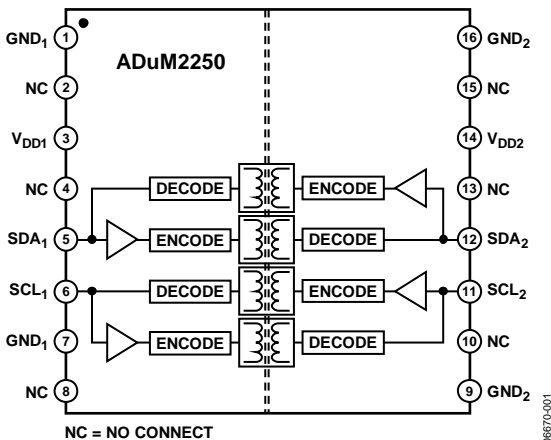
FUNCTIONAL BLOCK DIAGRAMS
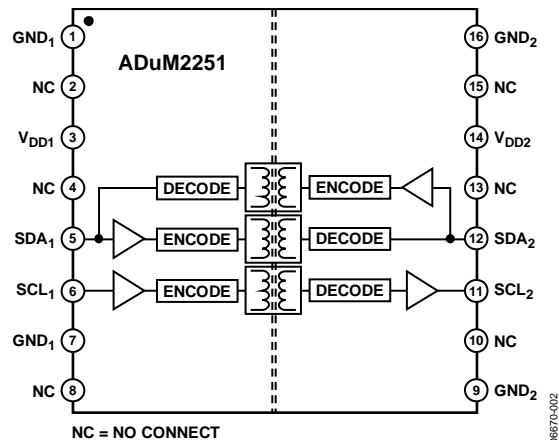

Figure 1. ADuM2250 Functional Block Diagram

Figure 2. ADuM2251 Functional Block Diagram

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REVISION HISTORY

9/11—Rev. 0 to Rev. A

4/07—Revision 0: Initial Version

SPECIFICATIONS

ELECTRICAL CHARACTERISTICS

DC Specifications

All voltages are relative to their respective ground. All minimum/maximum specifications apply over the entire recommended operating range, unless otherwise noted. All typical specifications are at T_A = 25°C, V_{DD1} = 5 V, and V_{DD2} = 5 V, unless otherwise noted.

Table 1.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions
ADuM2250						
Input Supply Current, Side 1, 5 V	I_{DD1}		2.8	5.0	mA	V_{DD1} = 5 V
Input Supply Current, Side 2, 5 V	I_{DD2}		2.7	5.0	mA	V_{DD2} = 5 V
Input Supply Current, Side 1, 3.3 V	I_{DD1}		1.9	3.0	mA	V_{DD1} = 3.3 V
Input Supply Current, Side 2, 3.3 V	I_{DD2}		1.7	3.0	mA	V_{DD2} = 3.3 V
ADuM2251						
Input Supply Current, Side 1, 5 V	I_{DD1}		2.8	6.0	mA	V_{DD1} = 5 V
Input Supply Current, Side 2, 5 V	I_{DD2}		2.5	4.7	mA	V_{DD2} = 5 V
Input Supply Current, Side 1, 3.3 V	I_{DD1}		1.8	3.0	mA	V_{DD1} = 3.3 V
Input Supply Current, Side 2, 3.3 V	I_{DD2}		1.6	2.8	mA	V_{DD2} = 3.3 V
LEAKAGE CURRENTS	I_{ISDA1}, I_{ISDA2}, I_{ISCL1}, I_{ISCL2}		0.01	10	µA	V_{SDA1} = V_{DD1}, V_{SDA2} = V_{DD2}, V_{SCL1} = V_{DD1}, V_{SCL2} = V_{DD2}
SIDE 1 LOGIC LEVELS						
Logic Input Threshold[1]	V_{SDA1IL}, V_{SCL1IL}	500		700	mV	
Logic Low Output Voltages	V_{SDA1OL}, V_{SCL1OL}	600		900	mV	I_{SDA1} = I_{SCL1} = 3.0 mA
		600		850	mV	I_{SDA1} = I_{SCL1} = 0.5 mA
Input/Output Logic Low Level Difference[2]	ΔV_{SDA1}, ΔV_{SCL1}	50			mV	
SIDE 2 LOGIC LEVELS						
Logic Low Input Voltage	V_{SDA2IL}, V_{SCL2IL}			$0.3 \times V_{DD2}$	V	
Logic High Input Voltage	V_{SDA2IH}, V_{SCL2IH}	$0.7 \times V_{DD2}$			V	
Logic Low Output Voltage	V_{SDA2OL}, V_{SCL2OL}			400	mV	I_{SDA2} = I_{SCL2} = 30 mA

[1] V_{IL} < 0.5 V, V_{IH} > 0.7 V.

[2] ΔV_{S1L} = V_{S1OL} − V_{S1IL}. This is the minimum difference between the output logic low level and the input logic low threshold within a given component. This ensures that there is no possibility of the part latching up the bus to which it is connected.

AC Specifications

All voltages are relative to their respective ground. All minimum/maximum specifications apply over the entire recommended operating range, unless otherwise noted. All typical specifications are at $T_A = 25°C$, $V_{DD1} = 5$ V, and $V_{DD2} = 5$ V, unless otherwise noted. See Figure 3 for a timing test diagram.

Table 2.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions
MAXIMUM FREQUENCY		1000			kHz	
OUTPUT FALL TIME						4.5 V $\leq V_{DD1}$, $V_{DD2} \leq 5.5$ V, $C_{L1} = 40$ pF, $R_1 = 1.6$ kΩ, $C_{L2} = 400$ pF, $R_2 = 180$ Ω
5 V Operation						
Side 1 Output ($0.9\ V_{DD1}$ to 0.9 V)	t_{f1}	13	26	120	ns	
Side 2 Output ($0.9\ V_{DD2}$ to $0.1\ V_{DD2}$)	t_{f2}	32	52	120	ns	
3 V Operation						3.0 V $\leq V_{DD1}$, $V_{DD2} \leq 3.6$ V, $C_{L1} = 40$ pF, $R_1 = 1.0$ kΩ, $C_{L2} = 400$ pF, $R_2 = 120$ Ω
Side 1 Output ($0.9\ V_{DD1}$ to 0.9 V)	t_{f1}	13	32	120	ns	
Side 2 Output ($0.9\ V_{DD2}$ to $0.1\ V_{DD2}$)	t_{f2}	32	61	120	ns	
PROPAGATION DELAY						4.5 V $\leq V_{DD1}$, $V_{DD2} \leq 5.5$ V, $C_{L1} = C_{L2} = 0$ pF, $R_1 = 1.6$ kΩ, $R_2 = 180$ Ω
5 V Operation						
Side 1 to Side 2, Rising Edge[1]	t_{PLH12}		95	130	ns	
Side 1 to Side 2, Falling Edge[2]	t_{PHL12}		162	275	ns	
Side 2 to Side 1, Rising Edge[3]	t_{PLH21}		31	70	ns	
Side 2 to Side 1, Falling Edge[4]	t_{PHL21}		85	155	ns	
3 V Operation						3.0 V $\leq V_{DD1}$, $V_{DD2} \leq 3.6$ V, $C_{L1} = C_{L2} = 0$ pF, $R_1 = 1.0$ kΩ, $R_2 = 120$ Ω
Side 1 to Side 2, Rising Edge[1]	t_{PLH12}		82	125	ns	
Side 1 to Side 2, Falling Edge[2]	t_{PHL12}		196	340	ns	
Side 2 to Side 1, Rising Edge[3]	t_{PLH21}		32	75	ns	
Side 2 to Side 1, Falling Edge[4]	t_{PHL21}		110	210	ns	
PULSE-WIDTH DISTORTION						4.5 V $\leq V_{DD1}$, $V_{DD2} \leq 5.5$ V, $C_{L1} = C_{L2} = 0$ pF, $R_1 = 1.6$ kΩ, $R_2 = 180$ Ω
5 V Operation						
Side 1 -to Side 2, $\lvert t_{PLH12} - t_{PHL12} \rvert$	PWD_{12}		67	145	ns	
Side 2 to Side 1, $\lvert t_{PLH21} - t_{PHL21} \rvert$	PWD_{21}		54	85	ns	
3 V Operation						3.0 V $\leq V_{DD1}$, $V_{DD2} \leq 3.6$ V, $C_{L1} = C_{L2} = 0$ pF, $R_1 = 1.0$ kΩ, $R_2 = 120$ Ω
Side 1 to Side 2, $\lvert t_{PLH12} - t_{PHL12} \rvert$	PWD_{12}		114	215	ns	
Side 2 to Side 1, $\lvert t_{PLH21} - t_{PHL21} \rvert$	PWD_{21}		77	135	ns	
COMMON-MODE TRANSIENT IMMUNITY[5]	$\lvert CM_H \rvert$, $\lvert CM_L \rvert$	25	35		kV/μs	

[1] t_{PLH12} propagation delay is measured from the Side 1 input logic threshold to an output value of $0.7\ V_{DD2}$.
[2] t_{PHL12} propagation delay is measured from the Side 1 input logic threshold to an output value of 0.4 V.
[3] t_{PLH21} propagation delay is measured from the Side 2 input logic threshold to an output value of $0.7\ V_{DD1}$.
[4] t_{PHL21} propagation delay is measured from the Side 2 input logic threshold to an output value of 0.9 V.
[5] CM_H is the maximum common-mode voltage slew rate that can be sustained while maintaining $V_O > 0.8\ V_{DD2}$. CM_L is the maximum common-mode voltage slew rate that can be sustained while maintaining $V_O < 0.8$ V. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges. The transient magnitude is the range over which the common mode is slewed.
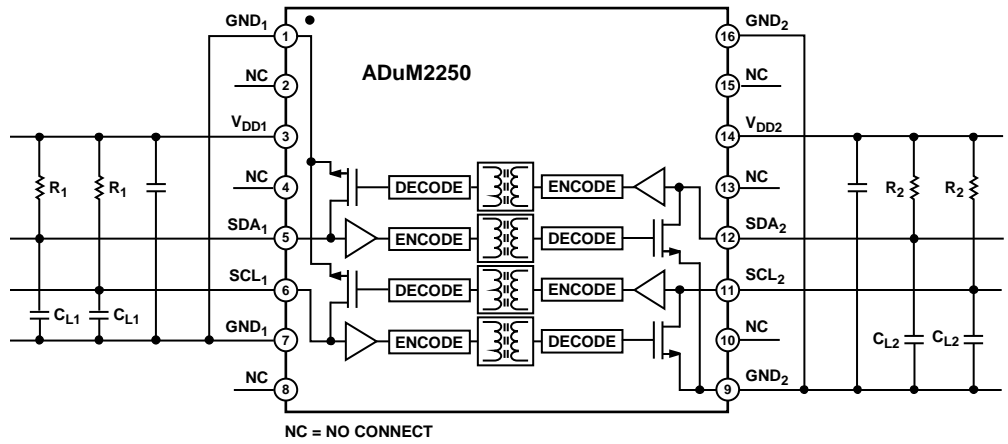
TEST CONDITIONS

Figure 3. Timing Test Diagram

PACKAGE CHARACTERISTICS

Table 3.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions
Resistance (Input to Output)[1]	R_{I-O}		10^{12}		Ω	
Capacitance (Input to Output)[1]	C_{I-O}		2.2		pF	f = 1 MHz
Input Capacitance	C_I		4.0		pF	
IC Junction-to-Ambient Thermal Resistance	$θ_{JA}$		45		°C/W	Thermocouple located at center of package underside

[1] The device is considered a 2-terminal device; Pin 1 to Pin 8 are shorted together, and Pin 9 to Pin 16 are shorted together.

REGULATORY INFORMATION

The ADuM2250/ADuM2251 is approved by the following organizations.

Table 4.

UL	CSA	VDE
Recognized under 1577 Component Recognition Program[1]	Approved under CSA Component Acceptance Notice #5A	Certified according to DIN V VDE V 0884-10 (VDE V 0884-10): 2006-12[2]
Single Protection 5000 V rms Isolation Voltage	Basic insulation per CSA 60950-1-07 and IEC 60950-1, 600 V rms (848 V peak) maximum working voltage RW-16 package. Reinforced insulation per CSA 60950-1-07 and IEC 60950-1, 380 V rms (537 V peak) maximum working voltage; reinforced insulation per IEC 60601-1 125 V rms (176 V peak) maximum working voltage RI-16 package Reinforced insulation per CSA 60950-1-07 and IEC 60950-1, 400 V rms (565 V peak) maximum working voltage; reinforced insulation per IEC 60601-1 250 V rms (353 V peak) maximum working voltage.	Reinforced insulation, 846 V peak
File E214100	File 205078	File 2471900-4880-0001

[1] In accordance with UL1577, each ADuM225x is proof tested by applying an insulation test voltage ≥ 6000 V rms for 1 second (current leakage detection limit = 10 µA).
[2] In accordance with DIN V VDE V 0884-10, each ADuM225x is proof tested by applying an insulation test voltage ≥1590 V peak for 1 sec (partial discharge detection limit = 5 pC). The * marking branded on the component designates DIN V VDE V 0884-10 approval.

INSULATION AND SAFETY-RELATED SPECIFICATIONS

Table 5.

Parameter	Symbol	Value	Unit	Conditions
Rated Dielectric Insulation Voltage		5000	V rms	1-minute duration
Minimum External Air Gap	L(I01)	8.0 min	mm	Distance measured from input terminals to output terminals, shortest distance through air along the PCB mounting plane, as an aid to PC board layout
Minimum External Tracking (Creepage) RW-16 Package	L(I02)	7.7 min	mm	Measured from input terminals to output terminals, shortest distance path along body
Minimum External Tracking (Creepage) RI-16 Package	L(I02)	8.3 min	mm	Measured from input terminals to output terminals, shortest distance path along body
Minimum Internal Gap (Internal Clearance)		0.017 min	mm	Insulation distance through insulation
Tracking Resistance (Comparative Tracking Index)	CTI	>175	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group		IIIa		Material Group (DIN VDE 0110, 1/89, Table 1)

DIN V VDE V 0884-10 (VDE V 0884-10) INSULATION CHARACTERISTICS

Note that the * marking on the package denotes DIN V VDE V 0884-10 approval for a 848 V peak working voltage. This isolator is suitable for reinforced isolation only within the safety limit data. Maintenance of the safety data is ensured by protective circuits.

Table 6.

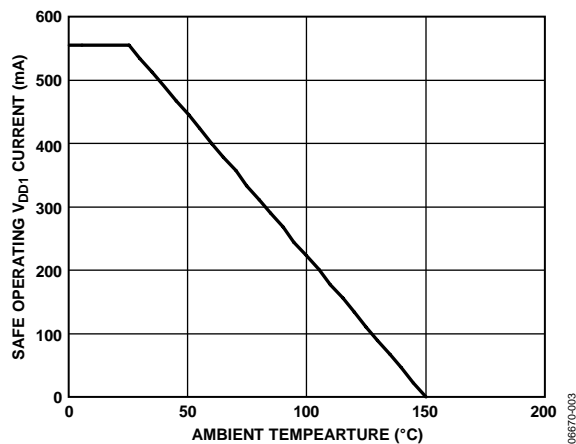| Description	Conditions	Symbol	Characteristic	Unit
Installation Classification per DIN VDE 0110				
For Rated Mains Voltage ≤ 300 V rms			I to IV	
For Rated Mains Voltage ≤ 450 V rms			I to II	
For Rated Mains Voltage ≤ 600 V rms			I to II	
Climatic Classification			40/105/21	
Pollution Degree (DIN VDE 0110, Table 1)			2	
Maximum Working Insulation Voltage		V_{IORM}	846	V peak
Input-to-Output Test Voltage, Method b1	$V_{IORM} \times 1.875 = V_{PR}$, 100% production test, t_m = 1 sec, partial discharge < 5 pC	V_{PR}	1590	V peak
Input-to-Output Test Voltage, Method a		V_{PR}		
After Environmental Tests Subgroup 1	$V_{IORM} \times 1.6 = V_{PR}$, t_m = 60 sec, partial discharge < 5 pC		1375	V peak
After Input and/or Safety Test Subgroup 2 and Subgroup 3	$V_{IORM} \times 1.2 = V_{PR}$, t_m = 60 sec, partial discharge < 5 pC		1018	V peak
Highest Allowable Overvoltage	Transient overvoltage, t_{TR} = 10 seconds	V_{TR}	6000	V peak
Safety-Limiting Values	Maximum value allowed in the event of a failure; see Figure 4			
Case Temperature		T_S	150	°C
Supply Current	$I_{DD1} + I_{DD2}$	I_S	555	mA
Insulation Resistance at T_S	V_{IO} = 500 V	R_S	>10^9	Ω

Figure 4. Thermal Derating Curve, Dependence of Safety-Limiting Values on Case Temperature, per DIN V VDE V 0884-10

RECOMMENDED OPERATING CONDITIONS

Table 7.

Parameter	Symbol	Min	Max	Unit
Operating Temperature	T_A	−40	+105	°C
Supply Voltages[1]	V_{DD1}, V_{DD2}	3.0	5.5	V
Input/Output Signal Voltage	V_{SDA1}, V_{SCL1}, V_{SDA2}, V_{SCL2}		5.5	V
Capacitive Load, Side 1	C_{L1}		40	pF
Capacitive Load, Side 2	C_{L2}		400	pF
Static Output Loading, Side 1	I_{SDA1}, I_{SCL1}	0.5	3	mA
Static Output Loading, Side 2	I_{SDA2}, I_{SCL2}	0.5	30	mA

[1] All voltages are relative to their respective ground.

ABSOLUTE MAXIMUM RATINGS

$T_A = 25°C$, unless otherwise noted.

Table 8.

Parameter	Symbol	Min	Max	Unit
Storage Temperature	T_{ST}	−65	+150	°C
Ambient Operating Temperature	T_A	−40	+105	°C
Supply Voltages[1]	V_{DD1}, V_{DD2}	−0.5	+7.0	V
Input/Output Voltage,[1] Side 1	V_{SDA1}, V_{SCL1}	−0.5	$V_{DD1} + 0.5$	V
Input/Output Voltage,[1] Side 2	V_{SDA2}, V_{SCL2}	−0.5	$V_{DD2} + 0.5$	V
Average Output Current, per Pin[2]	I_{O1}	−18	+18	mA
Average Output Current, per Pin[2]	I_{O2}	−100	+100	mA
Common-Mode Transients[3]		−100	+100	kV/μs

[1] All voltages are relative to their respective ground.
[2] See Figure 4 for maximum rated current values for various temperatures.
[3] Refers to common-mode transients across the insulation barrier. Common-mode transients exceeding the absolute maximum rating may cause latch-up or permanent damage.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

NC = NO CONNECT
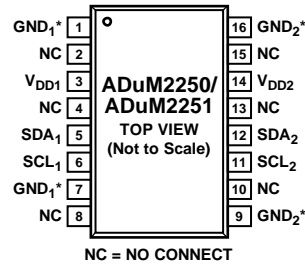
*PIN 1 AND PIN 7 ARE INTERNALLY CONNECTED. CONNECTING BOTH TO GND$_1$ IS RECOMMENDED. PIN 9 AND PIN 16 ARE INTERNALLY CONNECTED. CONNECTING BOTH TO GND$_2$ IS RECOMMENDED.

Figure 5. Pin Configuration

Table 9. ADuM2250 Pin Function Descriptions

Pin No.	Mnemonic	Description
1	GND$_1$	Ground 1. Ground reference for Isolator Side 1.
2	NC	No Connect.
3	V$_{DD1}$	Supply Voltage, 3.0 V to 5.5 V.
4	NC	No Connect.
5	SDA$_1$	Data Input/Output, Side 1.
6	SCL$_1$	Clock Input/Output, Side 1.
7	GND$_1$	Ground 1. Ground reference for Isolator Side 1.
8	NC	No Connect.
9	GND$_2$	Ground 2. Isolated ground reference for Isolator Side 2.
10	NC	No Connect.
11	SCL$_2$	Clock Input/Output, Side 2.
12	SDA$_2$	Data Input/Output, Side 2.
13	NC	No Connect.
14	V$_{DD2}$	Supply Voltage, 3.0 V to 5.5 V.
15	NC	No Connect.
16	GND$_2$	Ground 2. Isolated ground reference for Isolator Side 2.

Table 10. ADuM2251 Pin Function Descriptions

Pin No.	Mnemonic	Description
1	GND$_1$	Ground 1. Ground reference for Isolator Side 1.
2	NC	No Connect.
3	V$_{DD1}$	Supply Voltage, 3.0 V to 5.5 V.
4	NC	No Connect.
5	SDA$_1$	Data Input/Output, Side 1.
6	SCL$_1$	Clock Input, Side 1.
7	GND$_1$	Ground 1. Ground reference for Isolator Side 1.
8	NC	No Connect.
9	GND$_2$	Ground 2. Isolated ground reference for Isolator Side 2.
10	NC	No Connect.
11	SCL$_2$	Clock Output, Side 2.
12	SDA$_2$	Data Input/Output, Side 2.
13	NC	No Connect.
14	V$_{DD2}$	Supply Voltage, 3.0 V to 5.5 V.
15	NC	No Connect.
16	GND$_2$	Ground 2. Isolated ground reference for Isolator Side 2.

APPLICATIONS INFORMATION

FUNCTIONAL DESCRIPTION

The ADuM2250/ADuM2251 interface on each side to I^2C signals. Internally, the bidirectional I^2C signals are split into two unidirectional channels communicating in opposite directions via dedicated iCoupler isolation channels. One channel of each pair (the Side 1 input of each I/O pin in Figure 6) implements a special input buffer and output driver that can differentiate between externally generated inputs and its own output signals. It only transfers externally generated input signals to the corresponding Side 2 data or clock pin.

Both the Side 1 and the Side 2 I^2C pins are designed to interface to an I^2C bus operating in the 3.0 V to 5.5 V range. A logic low on either side causes the corresponding I/O pin across the coupler to be pulled low enough to comply with the logic low threshold requirements of other I^2C devices on the bus. Bus contention and latch-up is avoided by guaranteeing that the input low threshold at SDA_1 or SCL_1 is at least 50 mV less than the output low signal at the same pin. This prevents an output logic low at Side 1 being transmitted back to Side 2 and pulling down the I^2C bus by latching the state.

Because the Side 2 logic levels/thresholds and drive capabilities comply fully with standard I^2C values, multiple ADuM2250/ADuM2251 devices connected to a bus by their Side 2 pins can communicate with each other and with other devices having I^2C compatibility as shown in Figure 7. Note the distinction between I^2C compatibility and I^2C compliance. I^2C compatibility refers to situations in which the logic levels or drive capability of a component do not necessarily meet the requirements of the I^2C specification but still allow the component to communicate with an I^2C-compliant device. I^2C compliance refers to situations in which the logic levels and drive capability of a component fully meet the requirements of the I^2C specification.

Because the Side 1 pin has a modified output level/input threshold, Side 1 of the ADuM2250/ADuM2251 can only communicate with devices fully compliant with the I^2C standard. In other words, Side 2 of the ADuM2250/ADuM2251 is I^2C-compliant while Side 1 is only I^2C-compatible.

The Side 1 I/O pins must not be connected to other I^2C buffers that implement a similar scheme of dual I/O threshold detection. This latch-up prevention scheme is implemented in several popular I^2C level shifting and bus extension products currently available from Analog Devices and other manufacturers. Care should be taken to review the data sheet of potential I^2C bus buffering products to ensure that only one buffer on a bus segment implements a dual threshold scheme. A bus segment is a portion of the I^2C bus that is isolated from other portions of the bus by galvanic isolation, bus extenders, or level shifting buffers. Table 11 shows how multiple ADuM2250/ADuM2251 components can coexist on a bus as long as two Side 1 buffers are not connected to the same bus segment.

Table 11. ADuM225x Buffer Compatibility

	Side 1	Side 2
Side 1	No	Yes
Side 2	Yes	Yes

The output logic low levels are independent of the V_{DD1} and V_{DD2} voltages. The input logic low threshold at Side 1 is also independent of V_{DD1}. However, the input logic low threshold at Side 2 is designed to be at 0.3 V_{DD2}, consistent with I^2C requirements. The Side 1 and Side 2 I/O pins have open-collector outputs whose high levels are set via pull-up resistors to their respective supply voltages.
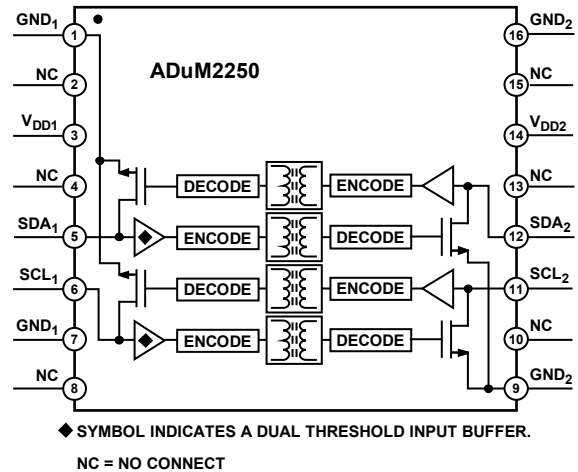

◆ SYMBOL INDICATES A DUAL THRESHOLD INPUT BUFFER.
NC = NO CONNECT

Figure 6. ADuM2250 Block Diagram

Figure 7 shows a typical application circuit including the pull-up resistors required for both Side 1 and Side 2 busses. Bypass capacitors of between 0.1 pF and 0.01 pF are required between V_{DD1} to GND_1 and V_{DD2} to GND_2. The 200 Ω resistor shown in Figure 7 is required for latch-up immunity if the ambient temperature can be between 105°C and 125°C.
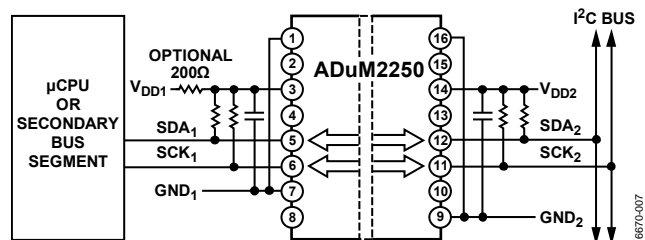

Figure 7. Typical Isolated I²C Interface Using ADuM2250

STARTUP

Both the V_{DD1} and V_{DD2} supplies have an under voltage lockout feature that prevents the signal channels from operating unless certain criteria is met. This feature is to avoid the possibility of input logic low signals from pulling down the I²C bus inadvertently during power-up/power-down.

Criteria that must be met for the signal channels to be enabled are as follows:

• Both supplies must be at least 2.5 V.
• At least 40 μs must elapse after both supplies exceed the internal start-up threshold of 2.0 V.

Until both of these criteria are met for both supplies, the ADuM2250/ADuM2251 outputs are pulled high thereby ensuring a startup that avoids any disturbances on the bus. Figure 8 and Figure 9 illustrate the supply conditions for fast and slow input supply slew rates.
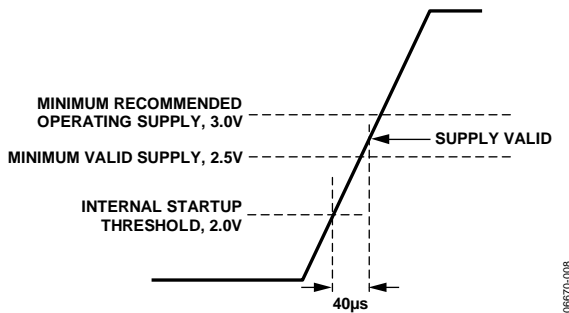

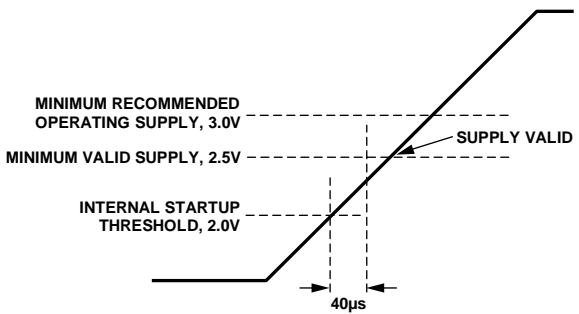Figure 8. Start-Up Condition, Supply Slew Rate < 12.5 V/ms

Figure 9. Start-Up Condition, Supply Slew Rate > 12.5 V/ms

MAGNETIC FIELD IMMUNITY

The ADuM2250/ADuM2251 are extremely immune to external magnetic fields. The limitation on the magnetic field immunity of the ADuM2250/ADuM2251 is set by the condition in which induced voltage in the receiving coil of the transformer is sufficiently large to either falsely set or reset the decoder. The following analysis defines the conditions under which this may occur. The 3 V operating condition of the ADuM2250/ADuM2251 is examined because it represents the most susceptible mode of operation.

The pulses at the transformer output have an amplitude greater than 1.0 V. The decoder has a sensing threshold at about 0.5 V, therefore establishing a 0.5 V margin in which induced voltages can be tolerated. The voltage induced across the receiving coil is given by

$$V = (-d\beta / dt) \sum \Pi r_n^2 \; ; n = 1, 2, ... N$$

where:
β is the magnetic flux density (gauss).
r_n is the radius of the nth turn in the receiving coil (cm).
N is the number of turns in the receiving coil.

Given the geometry of the receiving coil in the ADuM2250/ADuM2251 and an imposed requirement that the induced voltage be at most 50% of the 0.5 V margin at the decoder, a maximum allowable magnetic field is calculated, as shown in Figure 10.
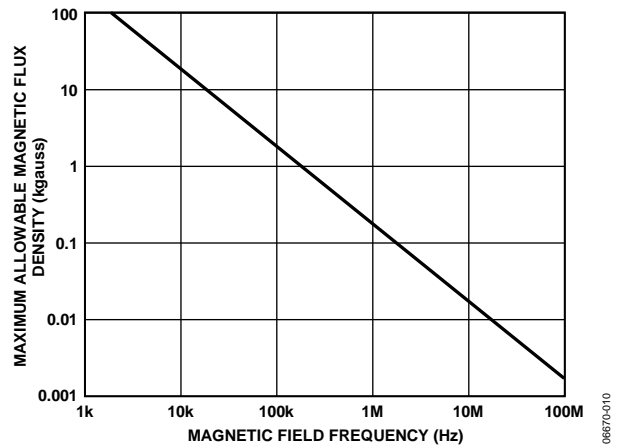

Figure 10. Maximum Allowable External Magnetic Flux Density

For example, at a magnetic field frequency of 1 MHz, the maximum allowable magnetic field of 0.2 kgauss induces a voltage of 0.25 V at the receiving coil. This is about 50% of the sensing threshold and does not cause a faulty output transition. Similarly, if such an event were to occur during a transmitted pulse (and had the worst-case polarity), it would reduce the received pulse from >1.0 V to 0.75 V (still well above the 0.5 V sensing threshold of the decoder).

The preceding magnetic flux density values correspond to specific current magnitudes at given distances away from the ADuM2250/ADuM2251 transformers. Figure 11 expresses these allowable current magnitudes as a function of frequency for selected distances. As seen, the ADuM2250/ADuM2251 is extremely immune and can be affected only by extremely large currents operated at high frequency and very close to the component. For the 1 MHz example, place a 0.5 kA current 5 mm away from the ADuM2250/ADuM2251 to affect the operation of the component.

Note that at combinations of strong magnetic fields and high frequencies, any loops formed by printed circuit board traces could induce sufficiently large error voltages to trigger the threshold of succeeding circuitry. Care should be taken in the layout of such traces to avoid this possibility.
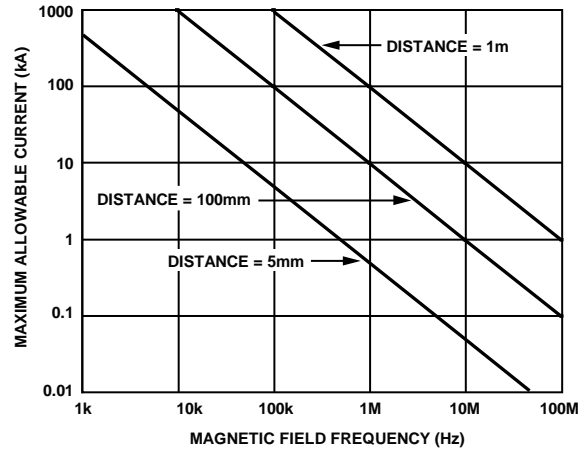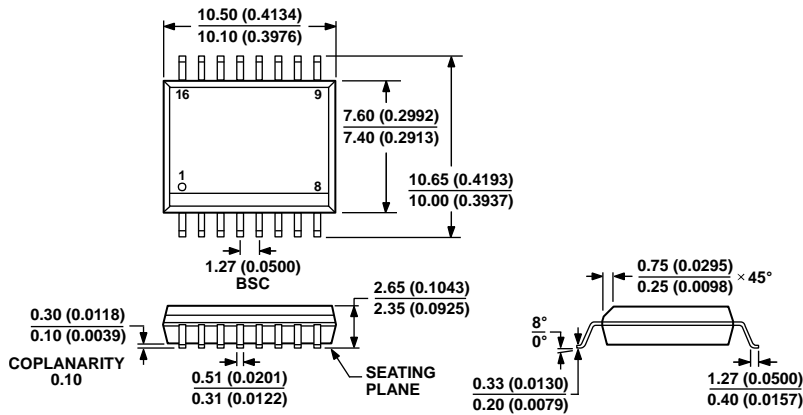

Figure 11. Maximum Allowable Current for Various Current-to-ADuM2250/ADuM2251 Spacings
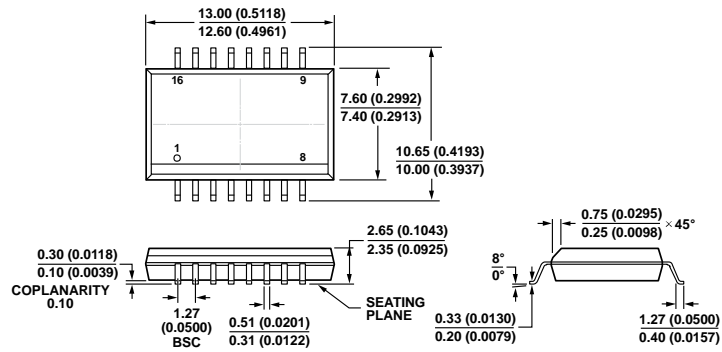
OUTLINE DIMENSIONS

COMPLIANT TO JEDEC STANDARDS MS-013-AA
CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS
(IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR
REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

03-27-2007-B

Figure 12. 16-Lead Standard Small Outline Package [SOIC_W]
Wide Body (RW-16)
Dimensions shown in millimeters (inches)

COMPLIANT TO JEDEC STANDARDS MS-013-AC
CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS
(IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR
REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

10-12-2010-A

Figure 13. 16-Lead Standard Small Outline Package, with Increased Creepage [SOIC_IC]
Wide Body (RI-16-1)
Dimension shown in millimeters and (inches)

ORDERING GUIDE

Model[1]	Number of Inputs, V_{DD1} Side	Number of Inputs, V_{DD2} Side	Maximum Data Rate (Mbps)	Temperature Range	Package Description	Package Option
ADuM2250ARWZ	2	2	1	−40°C to +105°C	16-Lead SOIC_W	RW-16
ADuM2250ARWZ-RL	2	2	1	−40°C to +105°C	16-Lead SOIC_W, 13" Reel	RW-16
ADuM2250ARIZ	2	2	1	−40°C to +105°C	16-Lead SOIC_IC	RI-16-1
ADuM2250ARIZ-RL	2	2	1	−40°C to +105°C	16-Lead SOIC_IC, 13" Reel	RI-16-1
ADuM2251ARWZ	2	1	1	−40°C to +105°C	16-Lead SOIC_W	RW-16
ADuM2251ARWZ-RL	2	1	1	−40°C to +105°C	16-Lead SOIC_W, 13" Reel	RW-16
ADuM2251ARIZ	2	1	1	−40°C to +105°C	16-Lead SOIC_IC	RI-16-1
ADuM2251ARIZ-RL	2	1	1	−40°C to +105°C	16-Lead SOIC_IC, 13" Reel	RI-16-1

[1] Z = RoHS Compliant Part.

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